


<b>Search Notes</b>  	<b>Application/Control No.</b>  10593107	<b>Applicant(s)/Patent Under Reexamination</b>  YUAN ET AL.
	<b>Examiner</b>  Hoai v Pham	<b>Art Unit</b>  2892

SEARCHED			
Class	Subclass	Date	Examiner
438	22,23,24,29	02/26/2010	HP
257	79,80,82,83,E21.053,E33.001	02/26/2010	HP

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	interference searched printout history	02/27/2010	HP

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